TOSHIBA TLP421

TOSHIBA PHOTOCOUPLER GaAs IRED & PHOTO-TRANSISTOR

TLP421

OFFICE EQUIPMENT

HOUSEHOLD APPLIANCES

SOLID STATE RELAYS

SWITCHING POWER SUPPLIES

VARIOUS CONTROLLERS

SIGNAL TRANSMISSION BETWEEN DIFFERENT VOLTAGE CIRCUITS

The TOSHIBA TLP421 consists of a silicone photo-transistor optically coupled to a gallium arsenide infrared emitting diode in a four lead plastic DIP (DIP4) with having high isolation voltage $(AC : 5k V_{RMS} (min)).$

Collector-Emitter Voltage : 80 V (min)

Current Transfer Ratio : 50% (min) Rank GB : 100% (min)

: 5000 V_{rms} (min) Isolation Voltage

UL Recognized : UL1577

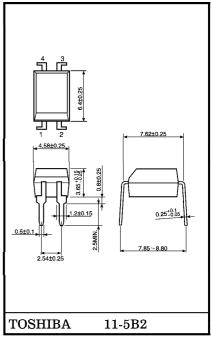
BSI Approved : BS EN60065 : 1994

> Approved No. 8411 BS EN60950: 1992 Approved No. 8412

SEMKO Approved : EN60065, EN60950, EN60335

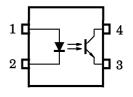
Approved No. 9910249/01

Unit in mm



Weight: 0.26 g

PIN CONFIGURATIONS (TOP VIEW)



1: ANODE 2: CATHODE 3: EMITTER 4 : COLLECTOR

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TOSHIBA TLP421

• Option (D4) type

TÜV Approved : DIN VDE0884

Approved No. R9950202

 $\begin{array}{lll} \mbox{Maximum Operating Insulation Voltage} & : 890 \ \mbox{V}_{\mbox{PK}} \\ \mbox{Maximum Permissible Overvoltage} & : 8000 \ \mbox{V}_{\mbox{PK}} \end{array}$

(Note): When a VDE0884 approved type is needed,

please designate the "Option (D4)"

Making the VDE Application: DIN VDE0884

Construction Mechanical Rating

	7.62 mm pich 10.16 mm p	
	Typical type	TLPxxxF type
Creepage Distance	7.0 mm (min)	8.0 mm (min)
Clearance	7.0 mm (min)	8.0 mm (min)
Insulation Thickness		0.4 mm (min)

CURRENT TRANSFER RATIO

TYPE	CLASSI- FICATION	CURRENT TRANSFER RATIO (%) $\frac{(I_C/I_F)}{I_F = 5 \text{ mA}, \ V_{CE} = 5 \text{ V}, \ Ta = 25^{\circ}C}$		MARKING OF CLASSIFICATION
	(*1)	MIN	MAX	
	(None)	50	600	Blank, Y, Y+, G, G+, B, B+, GB
	Rank Y	50	150	Y, Y+
TLP421	Rank GR	100	300	G, G+
	Rank BL	200	600	B, B+
	Rank GB	100	600	G, G+, B, B+, GB

(*1) : Ex. Rank GB : TLP421 (GB)

(Note): Application type name for certification test, please use standard product type

name, i.e.

TLP421 (GB): TLP421

MAXIMUM RATINGS (Ta = 25°C)

	CHARACTERISTIC	STMBOL	RATING	UNIT
	Forward Current	${ m I_F}$	60	mA
	Forward Current Derating (Ta ≥ 39°C)	△I _F /°C	-0.7	mA/°C
	Pulse Forward Current (Note 2)	I_{FP}	1	A
LE	Power Dissipation	$P_{\mathbf{D}}$	100	mW
	Power Dissipation Derating	△P _D /°C	-1.0	mW/°C
	Reverse Voltage	$v_{ m R}$	5	V
	Junction Temperature	T_{j}	125	°C
R	Collector-Emitter Voltage	v_{CEO}	80	V
O F	Emitter-Collector Voltage	v_{ECO}	7	V
L	Collector Current	$I_{\mathbf{C}}$	50	mA
EC	Power Dissipation (Single Circuit)	$P_{\mathbf{C}}$	150	mW
ET	Power Dissipation Derating (Ta ≥ 25°C) (Single Circuit)	△P _C /°C	-1.5	mW/°C
D	Junction Temperature	T_{j}	125	°C
Op	erating Temperature Range	$T_{ m opr}$	-55~100	°C
Sto	rage Temperature Range	$T_{ m stg}$	-55~125	°C
Lea	ad Soldering Temperature (10 s)	T_{sol}	260	°C
Tot	al Package Power Dissipation	P_{T}	250	mW
	al Package Power Dissipation Derating $2 \geq 25^{\circ}\text{C}$	$\Delta \mathrm{P_T}/\mathrm{^{\circ}C}$	-2.5	mW/°C
Iso	lation Voltage (Note 3)	$BV_{\mathbf{S}}$	5000	V _{rms}

(Note 2) : 100 μ s pulse, 100 Hz frequency

(Note 3): AC, 1 min., R.H. ≤ 60%. Apply voltage to LED pin and detector pin together.

RECOMMENDED OPERATING CONDITIONS

CHARACTERISTIC	SYMBOL	MIN	TYP.	MAX	UNIT
Supply Voltage	v_{CC}	_	5	24	V
Forward Current	$I_{\mathbf{F}}$	_	16	25	mA
Collector Current	$I_{\mathbf{C}}$	_	1	10	mA
Operating Temperature	${ m T_{opr}}$	-25	_	85	°C

INDIVIDUAL ELECTRICAL CHARACTERISTICS (Ta = 25°C)

	CHARACTERISTIC	SYMBOL	TEST CONDITION	MIN	TYP.	MAX	UNIT
Γ	Forward Voltage	$V_{\mathbf{F}}$	$I_{ m F}=10{ m mA}$	1.0	1.2	1.3	V
闰	Reverse Current	$I_{ m R}$	$V_R = 5 V$	_	_	10	μ A
-	Capacitance	C_{T}	V = 0, $f = 1 MHz$	_	30	_	рF
	Collector-Emitter Breakdown Voltage	V (BR) CEO	$I_{ m C}=0.5{ m mA}$	80	_	_	V
TOR	Emitter-Collector Breakdown Voltage	V _{(BR)ECO}	$I_{ m E}=0.1{ m mA}$	7	_	_	V
TEC'	Collector Dark Current	I_ (I_e= a)	$V_{CE} = 24 V$ (Ambient Light Below 1000 ℓx)	_	0.01 (0.1)	0.1 (10)	μ A
DET	Conector Dark Current	ID (ICEO)	$V_{CE} = 24 \text{ V}$ (Ambient Light) $Ta = 85^{\circ}\text{C}$ (Below 1000 ℓ x)	_	0.6 (1)	50 (50)	μ A
	Capacitance (Collector to Emitter)	c_{CE}	$V=0,\;f=1\;MHz$	_	10	_	pF

COUPLED ELECTRICAL CHARACTERISTICS (Ta = 25°C)

CHARACTERISTIC	SYMBOL	TEST CONDITION	MIN	TYP.	MAX	UNIT
Current Transfer Ratio	I _C /I _F	$ m I_F = 5~mA,~V_{CE} = 5~V$ Rank GB	50 100	_	600 600	%
Saturated CTR	I _C / I _F (sat)	$I_{ m F}=1~{ m mA},~{ m V}_{ m CE}=0.4~{ m V}$ Rank GB	-	60 —	_	- %
Callantan Emittan Catamatian		$I_{C} = 2.4 \text{ mA}, I_{F} = 8 \text{ mA}$	_	_	0.4	
Collector-Emitter Saturation Voltage	V _{CE} (sat)	$I_{\mathrm{C}} = 0.2 \mathrm{mA}, \; I_{\mathrm{F}} = 1 \mathrm{mA}$	_	0.2	_] v
Voltage	- (1	Rank GB	_	_	0.4	

ISOLATION CHARACTERISTICS (Ta = 25°C)

CHARACTERISTIC	SYMBOL	TEST CONDITION	MIN	TYP.	MAX	UNIT
Capacitance (Input to Output)	c_{S}	$V_{ m S}=0,~{ m f}=1~{ m MHz}$	_	0.8	_	pF
Isolation Resistance	RS	$V_S = 500 V$	$1 imes 10^{12}$	10^{14}		Ω
Isolation Voltage	BVS	AC, 1 minute	5000	_	_	37
		AC, 1 second, in oil	_	10000		V_{rms}
		DC, 1 minute, in oil	_	10000	_	Vdc

SWITCHING CHARACTERISTICS (Ta = 25°C)

CHARACTERISTICS	SYMBOL	TEST CONDITION	MIN	TYP.	MAX	UNIT
Rise Time	t_r		_	2	_	
Fall Time	tf	$V_{CC} = 10 \text{ V}, \text{ I}_{C} = 2 \text{ mA}$ $R_{L} = 100 \Omega$	_	3	_]
Turn-on Time	ton		_	3	_	μ s
Turn-off Time	$t_{ m off}$		_	3	_	
Turn-on Time	toN	D 101-0 (E:1)	_	2	_	
Storage Time	t_S	$R_{L} = 1.9 \text{ k}\Omega \qquad (\text{Fig.1})$ $V_{CC} = 5 \text{ V}, I_{F} = 16 \text{ mA}$	_	25		μ s
Turn-off Time	tOFF	$^{\circ}$ VCC = 5 v, $^{\circ}$ IF = 10 mA	_	50	_	

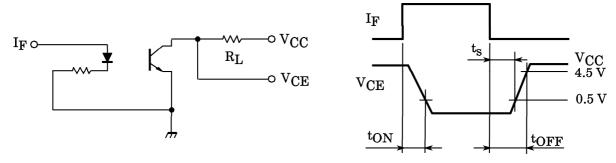
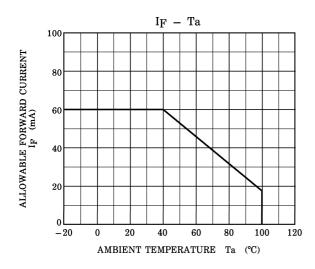
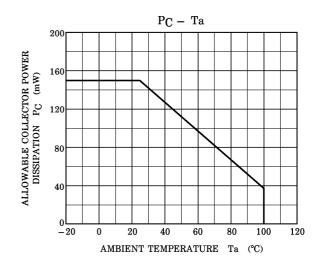
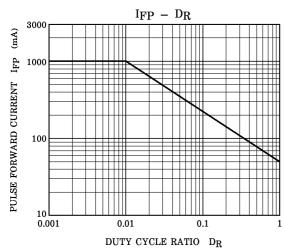
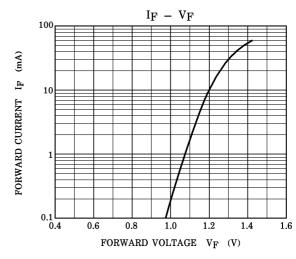


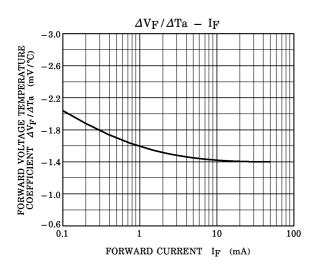
Fig.1 Switching Time Test Circuit

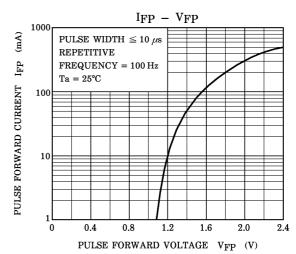


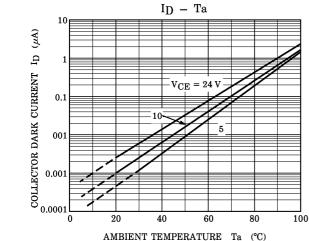


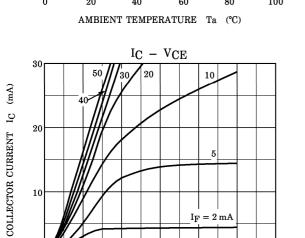








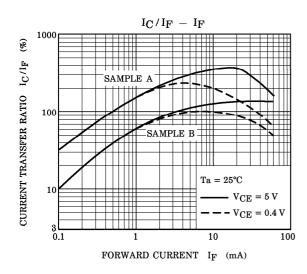




0.6

COLLECTOR-EMITTER VOLTAGE V_{CE} (V)

1.2



0.4

